



COMPLEMENTARY PAIR ENHANCEMENT MODE MOSFET

Product Summary

| Device | V _{(BR)DSS} | R _{DS(ON)} | I_{D} $T_{A} = +25^{\circ}C$ |
|--------|----------------------|--------------------------------|--------------------------------|
| Q1 | 25V | 4Ω @ $V_{GS} = 4.5V$ | 0.5A |
| Q2 | Q2 -12V | 55mΩ @ V _{GS} = -4.5V | -3.9A |
| Q2 | -12V | -3.5A | |

Description

This new generation MOSFET is designed to minimize the on-state resistance ($R_{DS(ON)}$) and yet maintain superior switching performance, making it ideal for high efficiency power management applications.

Applications

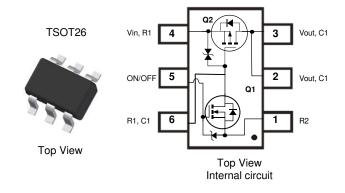
- DC-DC Converters
- Power Management Functions
- Load Switch

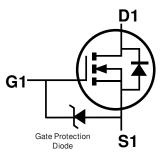
Features and Benefits

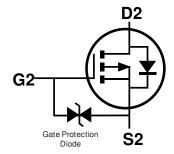
- Low On-Resistance
- Low Input Capacitance
- Fast Switching Speed
- Low Input/Output Leakage
- ESD Protected Gate
- Totally Lead-Free & Fully RoHS Compliant (Notes 1 & 2)
- Halogen and Antimony Free. "Green" Device (Note 3)
- Qualified to AEC-Q101 Standards for High Reliability

Mechanical Data

- Case: TSOT26
- Case Material: Molded Plastic, "Green" Molding Compound.
 UL Flammability Classification Rating 94V-0
- Moisture Sensitivity: Level 1 per J-STD-020
- Terminal Connections: See Diagram
- Terminals: Finish Matte Tin Annealed over Copper Leadframe.
 Solderable per MIL-STD-202, Method 208 @3
- Weight: 0.013 grams (Approximate)







Q1 N-Channel MOSFET

Q2 P-Channel MOSFET

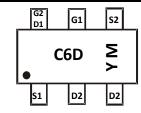
Ordering Information (Note 4)

| Part Number | Case | Packaging |
|---------------|--------|---------------------|
| DMC25D1UVT-7 | TSOT26 | 3000 / Tape & Reel |
| DMC25D1UVT-13 | TSOT26 | 10000 / Tape & Reel |

Notes:

- 1. No purposely added lead. Fully EU Directive 2002/95/EC (RoHS) & 2011/65/EU (RoHS 2) compliant.
- 2. See http://www.diodes.com/quality/lead_free.html for more information about Diodes Incorporated's definitions of Halogen- and Antimony-free, "Green" and Lead-free.
- 3. Halogen- and Antimony-free "Green" products are defined as those which contain <900ppm bromine, <900ppm chlorine (<1500ppm total Br + Cl) and <1000ppm antimony compounds.
- 4. For packaging details, go to our website at http://www.diodes.com/products/packages.html.

Marking Information



C6D = Product Type Marking Code YM or $\overline{Y}M$ = Date Code Marking Y or \overline{Y} = Year (ex: C = 2015) M = Month (ex: 9 = September)

Date Code Key

| Year | 201 | 5 | 2016 | | 2017 | 20 | 18 | 2019 | | 2020 | 2 | 2021 |
|-------|-----|-----|------|-----|------|-----|-----|------|-----|------|-----|------|
| Code | С | | D | | E F | | F G | | | Н | | |
| Month | Jan | Feb | Mar | Apr | May | Jun | Jul | Aug | Sep | Oct | Nov | Dec |
| Code | 1 | 2 | 3 | 4 | 5 | 6 | 7 | 8 | 9 | 0 | N | D |



Maximum Ratings – Q1 (@ $T_A = +25$ °C, unless otherwise specified.)

| Characteristic | Symbol | Value | Unit |
|----------------------------------------------------------|------------------|------------|------|
| Drain-Source Voltage | V _{DSS} | 25 | V |
| Gate-Source Voltage | V_{GSS} | -0.5 +8 | V |
| Continuous Drain Current (Note 5) V _{GS} = 4.5V | I _D | 0.5 | Α |
| Maximum Continuous Body Diode Forward Current (Note 6) | I _S | 1.2 | Α |
| Pulsed Drain Current (Note 6) | I _{DM} | 1.5 | Α |

Maximum Ratings – Q2 (@T_A = +25°C, unless otherwise specified.)

| Characteristic | | Symbol | Value | Unit |
|-----------------------------------------------------------|----------------|-----------------|-------|----------|
| Drain-Source Voltage | | V_{DSS} | -12 | V |
| Gate-Source Voltage | | V_{GSS} | ±8 | V |
| Continuous Drain Current (Note 5) V _{GS} = -4.5V | Steady State | | -3.9 | Α |
| Note 9 | | I_{D} | -17.4 | Α |
| Continuous Drain Current (Note 5) V _{GS} = -2.5V | | | -2.82 | Α |
| Maximum Continuous Body Diode Forward Current (Note 6) | I _S | -40 | Α | |
| Pulsed Drain Current (Note 6) | | I _{DM} | -40 | Α |

Thermal Characteristics

| Characteristic | | Symbol | Value | Unit | |
|--------------------------------------------------|----------------|-----------------|-------|------|--|
| Power Dissipation (Note 5) | | P_{D} | 1.3 | W | |
| Thermal Resistance, Junction to Ambient (Note 5) | Steady State | D | 100 | °C/W | |
| Thermal nesistance, junction to Ambient (Note 5) | Note 9 | $R_{\theta JA}$ | 5 | C/VV | |
| Thermal Resistance, Junction to Case (Note 5) | $R_{	heta JC}$ | 36 | °C/W | | |
| Operating and Storage Temperature Range | T_J, T_{STG} | -55 to +150 | °C | | |

Electrical Characteristics – Q1 (@T_A = +25°C, unless otherwise specified.)

| Characteristic | Symbol | Min | Тур | Max | Unit | Test Condition |
|--------------------------------------------|---------------------|------|------|-----|------|------------------------------------------------------------|
| OFF CHARACTERISTICS (Note 7) | | | | | | |
| Drain-Source Breakdown Voltage | BV_DSS | 25 | _ | _ | V | $V_{GS} = 0V, I_D = 250\mu A$ |
| Zero Gate Voltage Drain Current | I _{DSS} | _ | _ | 1 | μΑ | $V_{DS} = 20V$, $V_{GS} = 0V$ |
| Gate-Source Leakage | I _{GSS} | _ | _ | 100 | nA | $V_{GS} = 8V$, $V_{DS} = 0V$ |
| ON CHARACTERISTICS (Note 7) | | | | | | |
| Gate Threshold Voltage | $V_{GS(TH)}$ | 0.65 | 0.85 | 1.5 | V | $V_{DS} = V_{GS}, I_{D} = 250 \mu A$ |
| Static Drain-Source On-Resistance | R _{DS(ON)} | _ | 3.8 | 4 | Ω | $V_{GS} = 4.5V, I_D = 0.4A$ |
| Diode Forward Voltage | V_{SD} | _ | 0.76 | 1.2 | V | $V_{GS} = 0V, I_{S} = 0.29A$ |
| DYNAMIC CHARACTERISTICS (Note 8) | | | • | | • | • |
| Input Capacitance | Ciss | _ | 27.6 | _ | | V _{DS} = 10V, V _{GS} = 0V, f = 1.0MHz |
| Output Capacitance | Coss | _ | 8.5 | _ | рF | |
| Reverse Transfer Capacitance | C _{rss} | _ | 3.3 | _ | | I = 1.0IVIHZ |
| Gate Resistance | R_g | _ | 25 | _ | Ω | $V_{DS} = 0V$, $V_{GS} = 0V$, $f = 1MHz$ |
| Total Gate Charge (V _{GS} = 4.5V) | Q_g | | 0.4 | _ | | |
| Total Gate Charge (V _{GS} = 10V) | Q_g | _ | 0.9 | _ | nC | N/ 5 N/ 1 0 0 0 A |
| Gate-Source Charge | Q _{gs} | | 0.1 | _ | IIC | $V_{DS} = 5V$, $I_D = 0.2A$ |
| Gate-Drain Charge | Q_{gd} | _ | 0.04 | _ | | |
| Turn-On Delay Time | t _{D(ON)} | _ | 2.5 | _ | | |
| Turn-On Rise Time | t _R | _ | 1.4 | _ | | $V_{GS} = 4.5V, V_{DS} = 6V,$ |
| Turn-Off Delay Time | t _{D(OFF)} | _ | 5.7 | _ | ns | $R_G = 50\Omega, I_D = 0.5A$ |
| Turn-Off Fall Time | t _F | _ | 4.3 | _ | | |

Notes:

- 5. Device mounted on FR-4 substrate PC board, 2oz copper, with 1in. square copper plate.
 6. Repetitive rating, pulse width limited by junction temperature.
 7. Short duration pulse test used to minimize self-heating effect.
 8. Guaranteed by design. Not subject to production testing.
 9. Pulse Test: Pulse Width < 300µs, Duty Cycle < 2.0%.



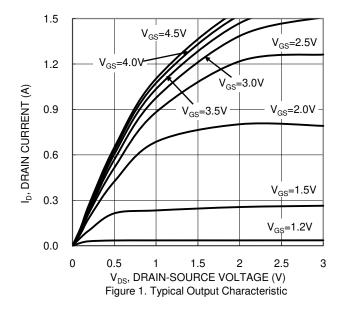
Electrical Characteristics – Q2 (@T_A = +25°C, unless otherwise specified.)

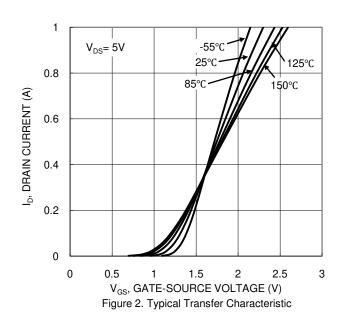
| Characteristic | Symbol | Min | Тур | Max | Unit | Test Condition |
|---------------------------------------------|---------------------|-------|------|------|------|-------------------------------------------------|
| OFF CHARACTERISTICS (Note 10) | | | | | | • |
| Drain-Source Breakdown Voltage | BV _{DSS} | -12 | _ | _ | V | $V_{GS} = 0V, I_{D} = -250\mu A$ |
| Zero Gate Voltage Drain Current | I _{DSS} | _ | _ | -1 | μΑ | $V_{DS} = -6.4V, V_{GS} = 0V$ |
| Gate-Source Leakage | I _{GSS} | _ | _ | ±10 | μΑ | $V_{GS} = \pm 8V$, $V_{DS} = 0V$ |
| ON CHARACTERISTICS (Note 10) | | | | | | |
| Gate Threshold Voltage | $V_{GS(TH)}$ | -0.35 | _ | -1.5 | V | $V_{DS} = V_{GS}, I_{D} = -250 \mu A$ |
| | | _ | _ | 55 | | $V_{GS} = -4.5V$, $I_D = -2.8A$ |
| Static Drain-Source On-Resistance | R _{DS(ON)} | _ | _ | 70 | mΩ | $V_{GS} = -2.5V, I_D = -2.5A$ |
| | , , | _ | _ | 100 | | $V_{GS} = -1.8V, I_D = -2.0A$ |
| Diode Forward Voltage | V _{SD} | _ | _ | -1.2 | V | $V_{GS} = 0V, I_{S} = -0.6A$ |
| DYNAMIC CHARACTERISTICS (Note 11) | | | | | | |
| Input Capacitance | C _{iss} | _ | 9.7 | _ | | ., ., ., ., |
| Output Capacitance | Coss | _ | 393 | _ | pF | $V_{DS} = -6V$, $V_{GS} = 0V$, $I_{f} = 1MHz$ |
| Reverse Transfer Capacitance | C _{rss} | _ | 1.9 | _ | | I = IIVIMZ |
| Gate Resistance | Rq | _ | 1846 | _ | Ω | $V_{DS} = 0V$, $V_{GS} = 0V$, $f = 1MHz$ |
| Total Gate Charge (V _{GS} = -4.5V) | Qg | _ | 24.5 | _ | | |
| Gate-Source Charge | Qgs | _ | 3.3 | _ | nC | $V_{DS} = -6V, I_{D} = -2.8A$ |
| Gate-Drain Charge | Q _{ad} | _ | 7.3 | _ | | |
| Turn-On Delay Time | t _{D(ON)} | _ | 1.2 | _ | | |
| Turn-On Rise Time | t _R | _ | 2.7 | _ | 1 | $V_{GS} = -4.5V, V_{DS} = -6V,$ |
| Turn-Off Delay Time | t _{D(OFF)} | _ | 9.8 | _ | | $R_G = 6\Omega$, $I_D = -2.8A$ |
| Turn-Off Fall Time | t _F | _ | 6.5 | _ | 1 | |

Notes:

- 10. Short duration pulse test used to minimize self-heating effect.
- 11. Guaranteed by design. Not subject to production testing.

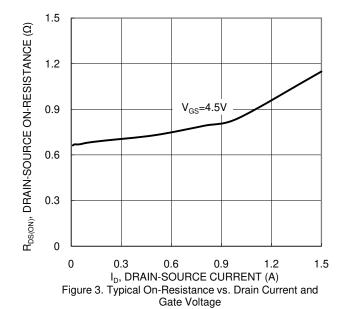
Typical Characteristics - N-CHANNEL

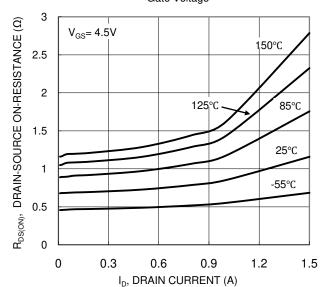


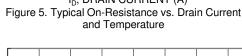












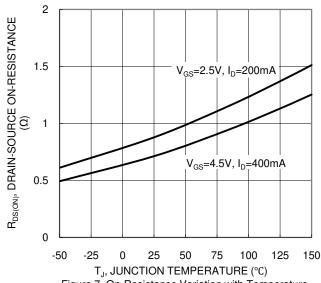
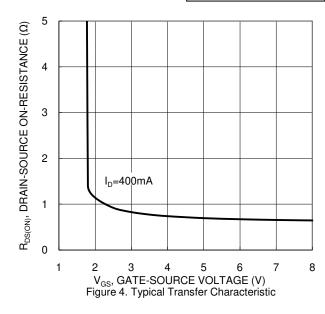


Figure 7. On-Resistance Variation with Temperature



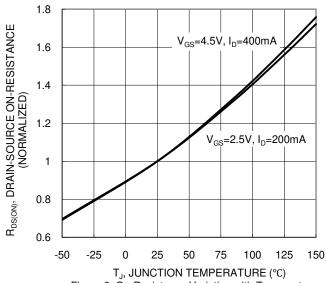
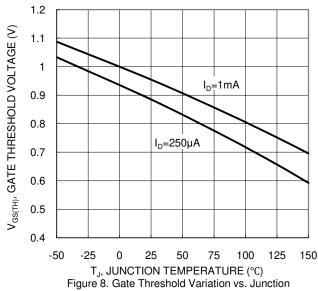
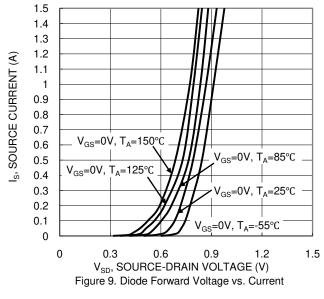


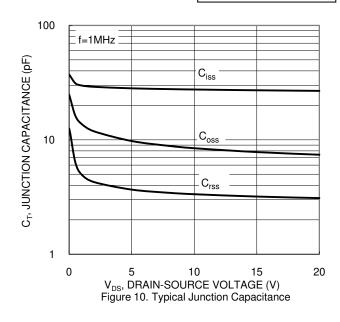
Figure 6. On-Resistance Variation with Temperature

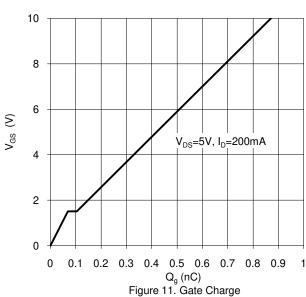


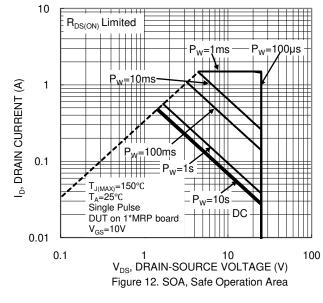
Temperature











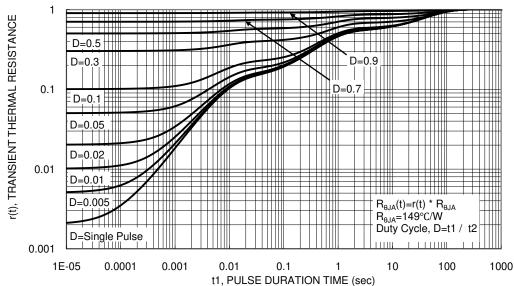
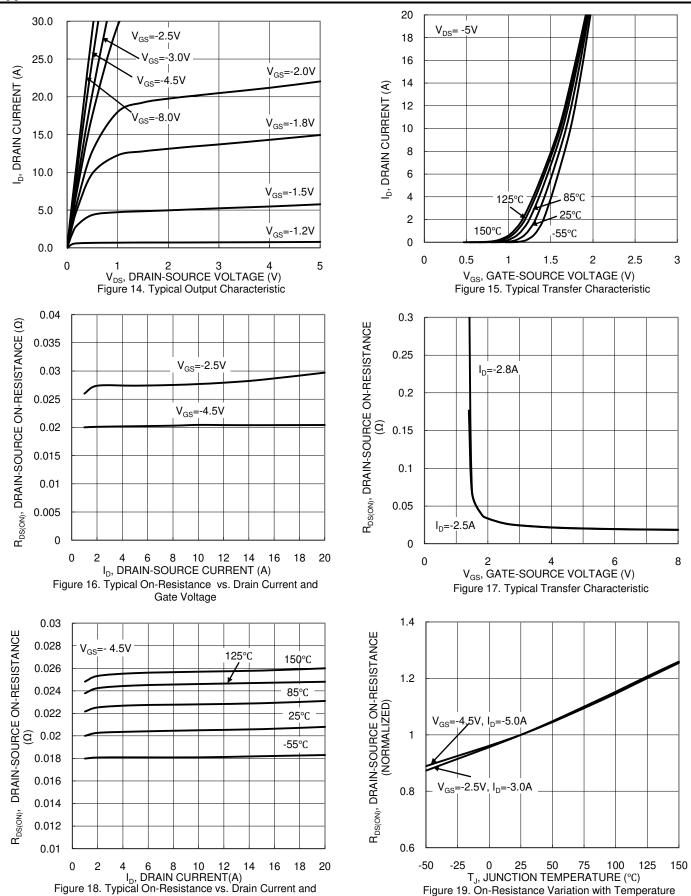


Figure 13. Transient Thermal Resistance



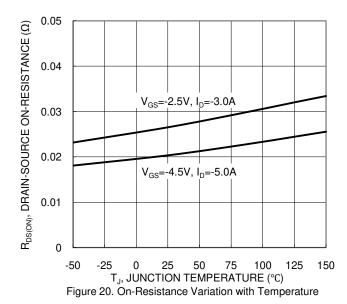
Typical Characteristics - P-CHANNEL

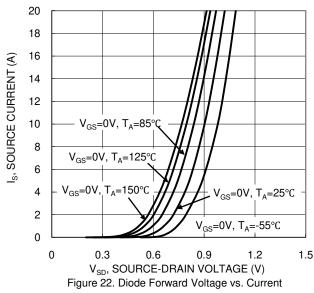


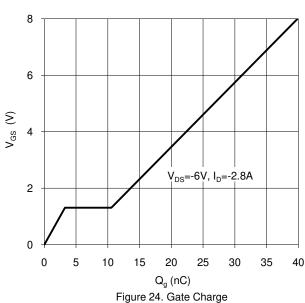
Temperature











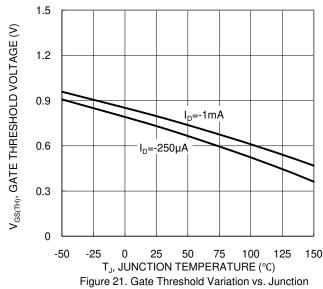
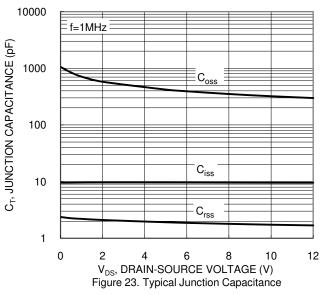
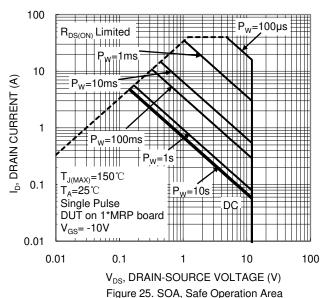


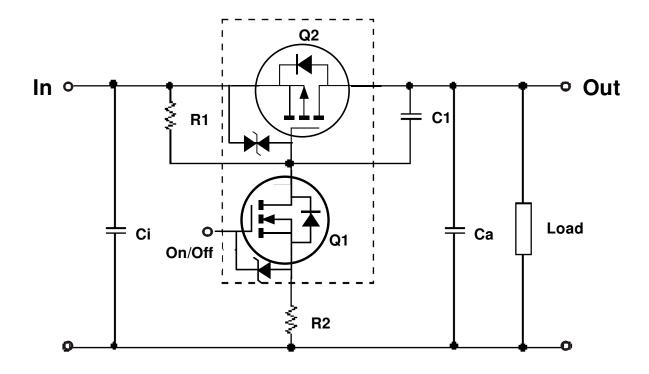
Figure 21. Gate Threshold Variation vs. Junction Temperature





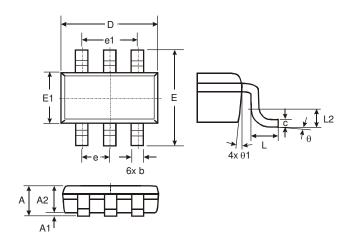


Application Circuit



Package Outline Dimensions

Please see AP02002 at http://www.diodes.com/datasheets/ap02002.pdf for the latest version.

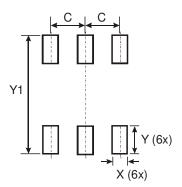


| TSOT26 | | | | | | |
|------------|----------------------|------|------|--|--|--|
| Dim | Min | Max | Тур | | | |
| Α | _ | 1.00 | _ | | | |
| A 1 | 0.01 | 0.10 | - | | | |
| A2 | 0.84 | 0.90 | _ | | | |
| D | _ | _ | 2.90 | | | |
| Е | _ | _ | 2.80 | | | |
| E1 | _ | _ | 1.60 | | | |
| b | 0.30 | 0.45 | _ | | | |
| С | 0.12 | 0.20 | _ | | | |
| е | _ | _ | 0.95 | | | |
| e1 | _ | _ | 1.90 | | | |
| L | 0.30 | 0.50 | | | | |
| L 2 | _ | _ | 0.25 | | | |
| θ | 0° | 8° | 4° | | | |
| θ1 | 4° | 12° | _ | | | |
| All D | All Dimensions in mm | | | | | |



Suggested Pad Layout

Please see AP02001 at http://www.diodes.com/datasheets/ap02001.pdf for the latest version.



| Dimensions | Value (in mm) |
|------------|---------------|
| С | 0.950 |
| Х | 0.700 |
| Υ | 1.000 |
| Y1 | 3.199 |

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